# Advanced Optical Imaging Technologies VII

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12–13 October 2024 Nantong, China

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Published by SPIE

Volume 13238

Proceedings of SPIE 0277-786X, V. 13238

SPIE is an international society advancing an interdisciplinary approach to the science and application of light.

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Please use the following format to cite material from these proceedings: Author(s), "Title of Paper," in Advanced Optical Imaging Technologies VII, edited by Xiao-Cong Yuan, P. Scott Carney, Kebin Shi, Proc. of SPIE 13238, Seven-digit Article CID Number (DD/MM/YYYY); (DOI URL).

ISSN: 0277-786X ISSN: 1996-756X (electronic)

ISBN: 9781510682047 ISBN: 9781510682054 (electronic)

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